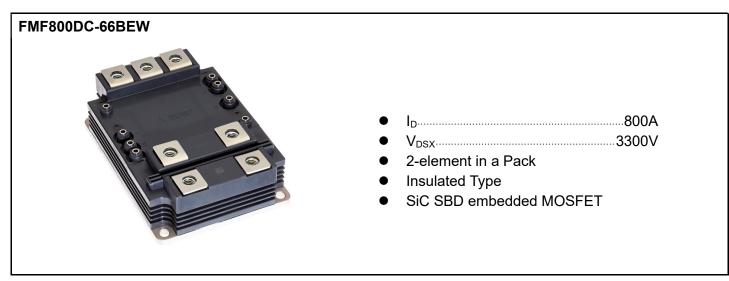


FMF800DC-66BEW

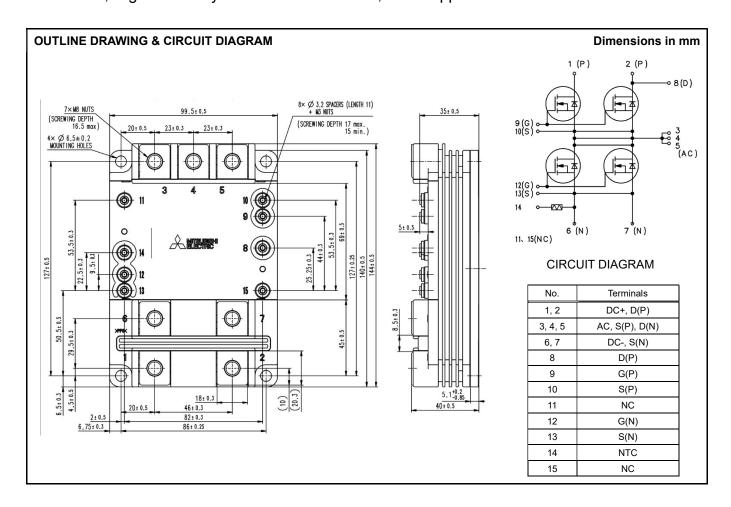
HIGH POWER SWITCHING USE

INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



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HIGH POWER SWITCHING USE

INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

MAXIMUM RATINGS

Item	Item Symbol Condition				Unit
Drain-Source voltage, specified gate-source voltage	V _{DSX}	V _{GS} = -7 V	3300	V	
Gate-Source voltage	V _{GSS}	V _{DS} = 0 V	±20	V	
Drain current	I _D	V _{GS} = 17 V , T _c = 87 °C , AC terminal output current (Note 1)			А
Drain current	I _{DP}	Non repetitive pulse	1600	Α	
Reverse drain current (FWD forward current)	Is	V_{GS} = -7 V , T_c = 85 °C , AC terminal output current(Note 1)(Note 2)	•	800	А
Reverse drain current (FWD forward current)	I _{SP}	Non repetitive pulse(Note 2)	$T_j = T_{op}$	1600	А
Total power dissipation	P _{tot}	T _c = 25 °C , MOSFET part(Note 3)	•	6650	W
Isolation voltage	V _{isol}	Charge part to the baseplate RMS sinusoidal, 60Hz 1min	6000	V _{rms}	
Partial discharge charge	Q _{pd}	Charged part to the baseplate RMS sinusoidal, 60 Hz 1min V1 = 3500 V, V2 = 2600 V(acc. to IEC 61287-1)	10	pC	
Junction temperature	Tj	Maximum temperature range in off-state or on-state(non-switching)	-40~175	°C	
Case temperature	Tc	Maximum case temperature range in on-state	-40~150	°C	
Storage temperature	T _{stg}	Maximum case temperature range in off-state	-50~175	°C	
Operating junction temperature	T _{jop}	Maximum junction temperature range for switching operation			°C
Short-circuit withstand pulse duration	t _{pSC}	$V_{DD} = 2500 \text{ V}$, $V_{GS} = +17 \text{ / -7 V}$, $L_s = 40 \text{ nH}$, $V_{GS}50\% - V_{GS}50\%$ $T_j = T_{op}$		1.7	μs
Short circuit energy	Esc	V_{DD} = 2500 V , F(t)weibull=1% $T_j = T_{op}$		35	J
Non-repetitive surge forward current	I _{FSM}	t_p = 10ms, $T_j = 175 ^{\circ}\text{C}$ F(t)weibull=1%, Half sinewave		5.9	kA
I2t value	I ² t	t_{b} = 10ms, $F(t)$ weibull=1%, Half sinewave			kA ² s

ELECTRICAL CHARACTERISTICS

Item Symbol		Condition		Limits			Unit	
				Min.	Тур.	Max.	Offic	
Gate-source leakage current	I _{GSS}	$V_{DS} = 0 \text{ V}$, $V_{GS} = V_{GSS}$	T _j = 25 °C	-2.0	•	2.0	μΑ	
			T _j = 25 °C	-	0.003	-	mA	
Drain-source cut-off current	I _{DSX}	$V_{DS} = V_{DSX}$, $V_{GS} = -7 V$	T _j = 150 °C	-	0.050	-	mΑ	
			T _j = 175 °C		0.080	3.0	mA	
			T _j = 25 °C	1.60	2.10	2.60	V	
Gate-source threshold voltage	$V_{GS(th)}$	$V_{DS} = 10 \text{ V}$, $I_{D} = 80 \text{mA}$	T _j = 150 °C	-	1.50	-	V	
			T _j = 175 °C	0.90	1.45	1.90	V	
	r _{DS(on)}	$V_{DS} = V_{DS(on)}$, $V_{GS} = 17 \text{ V}$, P-side(Terminal 8-10)	T _j = 25 °C		2.00	-	mΩ	
			T _j = 150 °C	-	4.31	-	mΩ	
			T _j = 175 °C	-	5.00	6.06	mΩ	
Drain-source on resistance		$V_{DS} = V_{DS(on)}$, $V_{GS} = 17 \text{ V}$, N-side(Terminal 10-13),(Note 5)	T _j = 25 °C		2.25	-	mΩ	
			T _j = 150 °C	-	4.63	-	mΩ	
			T _j = 175 °C	-	5.38	6.44	mΩ	
Drain-source on-state voltage		I_D = 800 A , V_{GS} = 17 V , P-side(Terminal 8-10)(Note 4)	T _j = 25 °C	-	1.60	-	V	
			T _j = 150 °C		3.45	-	V	
	V _{DS} (on)		T _j = 175 °C	-	4.00	4.85	V	
		I _D = 800 A , V _{GS} = 17 V , N-side(Terminal 10-13),(Note 4))(Note 5)	T _j = 25 °C	-	1.80	-	V	
			T _j = 150 °C	-	3.70	-	V	
			T _j = 175 °C	-	4.30	5.15	V	

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HIGH POWER SWITCHING USE

INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

ELECTRICAL CHARACTERISTICS (continuation)

					Limits		
Item	Symbol	Condition			Тур.	Max.	Unit
			T _i = 25 °C	Min.	1.45	-	V
		I _S = 800 A , V _{GS} = 17 V , P-side(Terminal 8-10)(Note 4)	T _i = 150 °C	-	3.25	-	v
		1.5 000 11, 105 11 1 1, 1 0100(101111111111111111111111	T _i = 175 °C	_	3.80	4.40	V
Source-drain voltage	V _{SD(on)}		T _i = 25 °C	-	1.65	-	V
		I _S = 800 A , V _{GS} = 17 V , N-side(Terminal 10-13),(Note 4))(Note 5)	T _i = 150 °C	_	3.50	-	V
		15 = 000 A, V65 = 17 V, 14-side(16111111ai 10-10),(140te 4))(140te 5)	T _i = 175 °C	_	4.10	4.70	V
			T _i = 25 °C	_			V
		- 000 A		-	2.00	-	V
		I _S = 800 A , V _{GS} = 0 V , P-side(Terminal 8-10)(Note 4)	T _j = 150 °C	-	3.85	- - 00	V
Source-drain voltage	V _{SD}		T _j = 175 °C	-	4.35	5.00	_
-		000 A V 000 A V 5 1 (T 1 1 1 40 40) (A) (A) (A) (A)	T _j = 25 °C	-	2.20	-	V
		$I_S = 800 \text{ A}$, $V_{GS} = 0 \text{ V}$, N-side(Terminal 10-13),(Note 4))(Note 5)	T _j = 150 °C	-	4.10	-	V
			T _j = 175 °C	-	4.65	5.30	V
			T _j = 25 °C	-	2.00	-	V
		I_S = 800 A , V_{GS} = -7 V , P-side(Terminal 8-10)(Note 4)	T _j = 150 °C	-	3.85	-	V
Source-drain voltage	V		T _j = 175 °C	-	4.35	5.00	V
Source-drain voltage	$V_{SD(off)}$		T _j = 25 °C	-	2.20	-	V
		I _S = 800 A , V _{GS} = -7 V , N-side(Terminal 10-13),(Note 4))(Note 5)	T _j = 150 °C	-	4.10	-	V
			T _i = 175 °C	-	4.65	5.30	٧
Input capacitance	Ciss	V _{DS} = 10 V , V _{GS} = 0 V , f = 100kHz , 1/2 module	T _i = 25 °C	-	110	-	nF
Output capacitance	Coss	V _{DS} = 10 V , V _{GS} = 0 V , f = 100kHz , 1/2 module	T _i = 25 °C	-	70	-	nF
Reverse transfer capacitance	Crss	V _{DS} = 10 V , V _{GS} = 0 V , f = 100kHz , 1/2 module	T _i = 25 °C	-	2.7	-	nF
Gate charge	Q _G	V _{DD} = 1800 V , I _D = 800 A , V _{GS} = +17 / -7 V , 1/2 module	T _i = 25 °C	_	3.3	-	μC
Turn-on delay time	t _{d(on)}	V _{DD} = 1800 V , I _D = 800 A , V _{GS} = +17 / -7 V , I _Z inequals	T _i = 175 °C	_	-	0.50	μs
Rise time	ta(on)	V _{DD} = 1800 V , I _D = 800 A , V _{GS} = +17 / -7 V , L _S = 40 nH	T _i = 175 °C	_	_	0.30	μs
ruse unie	ly.	V_{DD} = 1800 V , I_D = 800 A , V_{GS} = +17 / -7 V , L_s = 40 nH $R_{G(on)}$ = 1.5 Ω , $R_{G(off)}$ = 1.5 Ω , Inductive load	T _i = 25 °C	_	0.26	-	J
Turn-on (switching) energy per pulse 10% integral	E			-	0.20		J
Turn-orr (switching) energy per pulse 1070 integral	E _{on(10%)}		T _j = 150 °C			-	_
			T _j = 175 °C	-	0.22	-	J
_ , ,	E _{on}	V_{DD} = 1800 V , I_D = 800 A , V_{GS} = +17 / -7 V , L_s = 40 nH $R_{G(on)}$ = 1.5 Ω , $R_{G(off)}$ = 1.5 Ω , Inductive load	T _j = 25 °C	-	0.27	-	J
Turn-on (switching) energy per pulse			T _j = 150 °C	-	0.23	-	J
			T _j = 175 °C	-	0.23	-	J
		$V_{DD}=1800~V$, $I_D=800~A$, $V_{GS}=+17~/$ -7 V , $L_s=40~nH$ $R_{G(on)}=1.5~\Omega$, $R_{G(off)}=1.5~\Omega$, Inductive load	T _j = 25 °C	-	10.7	-	μC
Total capacitive charge	Q_C		T _j = 150 °C	-	12.5	-	μC
			T _j = 175 °C	-	12.5	-	μC
		V_{DD} = 1800 V , I_D = 800 A , V_{GS} = +17 / -7 V , L_s = 40 nH $R_{G(on)}$ = 1.5 Ω , $R_{G(off)}$ = 1.5 Ω , Inductive load	T _j = 25 °C	-	0.004	-	J
Diode turn-off energy (per pulse)	E _{off_Diode(10%)}		T _j = 150 °C	-	0.005	-	J
			T _j = 175 °C	-	0.005	-	J
		\\\ - 1900\\\\ \- 900\\\\\\\\\\\\\\\\\\\\\\\\\\	T _j = 25 °C	-	0.004	-	J
Diode switching off energy of diode	E _{off_Diode}	$V_{DD} = 1800 \text{ V}$, $I_D = 800 \text{ A}$, $V_{GS} = +17 / -7 \text{ V}$, $L_s = 40 \text{ nH}$	T _i = 150 °C	-	0.006	-	J
0 0,	_	$R_{G(on)}$ = 1.5 Ω , $R_{G(off)}$ = 1.5 Ω , Inductive load	T _i = 175 °C	-	0.006	-	J
Turn-off delay time	t _{d(off)}	$V_{DD} = 1800 \text{ V}$, $I_D = 800 \text{ A}$, $V_{GS} = +17 / -7 \text{ V}$, $L_s = 40 \text{ nH}$	T _i = 175 °C	-	-	0.94	μs
Fall time	t _f	V _{DD} = 1800 V , I _D = 800 A , V _{GS} = +17 / -7 V , L _s = 40 nH	T _i = 175 °C	-	-	0.40	μs
	Foff(10%)		T _i = 25 °C	-	0.10	-	J
Turn-off (switching) energy per pulse 10% integral		$V_{DD}=1800~V~,~I_D=800~A~,~V_{GS}=+17~/~-7~V~,~L_s=40~nH$ $R_{G(on)}=1.5~\Omega~,~R_{G(off)}=1.5~\Omega~,~Inductive~load$	T _i = 150 °C	_	0.11	-	J
Turn-on (switching) energy per pulse 10% Integral			T _i = 175 °C	-	0.11	-	J
	-		T _i = 25 °C	-	0.11	-	J
Turn off (quitabing) aparay per sules	E	$V_{DD} = 1800 \text{ V}, I_D = 800 \text{ A}, V_{GS} = +177 - 7 \text{ V}, L_S = 40 \text{ nH}$ $R_{Con} = 15.0 R_{Con} = 15.0 Inductive load$					
Turn-off (switching) energy per pulse	E _{off}		T _j = 150 °C	-	0.11	-	J
	1		T _j = 175 °C	-	0.11		J

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HIGH POWER SWITCHING USE

INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

THERMAL CHARACTERISTICS

Item	Symbol	Conditions		Limits		
nem Symbol		Conditions		Тур.	Max.	Unit
Thermal resistance junction to case	R _{th(j-c)}	Junction to Case, MOSFET + embeded SBD part, 1/2 module	ı	-	22.5	K/kW
Contact thermal resistance case to heatsink	R _{th(c-s)}	Case to heat sink, λ_{grease} = 1W/m·K, $D_{(c-s)}$ = 70µm, 1/2 module	-	22.5	-	K/kW

MECHANICAL CHARACTERISTICS

Item	Cumbal	Conditions	Conditions			
item	Symbol	Symbol Conditions		Тур.	Max.	Unit
Mounting torque	$M_{\rm t}$	Main terminal screw M8 This is the case when installing the product on the bus bar		-	22.0	N∙m
Mounting torque	Mt	Mounting screw M6	3.0	-	6.0	N·m
Mounting torque	M _t	Auxiliary terminals screw M3	0.4	-	0.8	N⋅m
Mass	m	-	-	0.8	-	kg
Comparative tracking index	CTI	-	600	-	-	-
Clearance distance in air	da	Between main terminal	8.0	-	-	mm
Creepage distance along surface	ds	-	32.0	-	-	mm
Internal inductance, D-S	L _{PDS}	Between DC+ and DC-(terminal1,2-6,7)	-	15	-	nΗ
	L _{PDS}	Between DC+ and AC (terminal1,2-3,4,5)	-	43	-	nΗ
	L _{PDS}	Between AC and DC-(terminal3,4,5-6,7)	-	43	-	nH
	R _{DD'+SS'}	T _C =25°C, Between DC+ and DC-(terminal1,2-6,7)	-	0.46	-	mΩ
Internal lead resistance, DD'-SS'	R _{DD'+SS'}	T _C =25°C, Between DC+ and AC(terminal1,2-3,4,5)	-	0.22	-	mΩ
	R _{DD'+SS'}	T _C =25°C,Between AC and DC-(terminal3,4,5-6,7)	-	0.33	-	mΩ
Zero-power resistance	R ₂₅	T _C =25°C	4.65	5.00	5.35	kΩ
B-constant	B _(25/50)	Approximate by equation,(Note 6)	-	3375	-	K

Note 1. Control Case Temperature (Tc) so that the junction temperature (Tj) does not exceed the maximum rating.

Note 5. N-side characteristic value includes wiring resistance between P-side source potential and N-side drain potential. (P-side characteristic value corresponds to chip characteristics).

Note 6.
$$B_{(25/50)} = \ln(\frac{R_{25}}{R_{50}}) / (\frac{1}{T_{25}} - \frac{1}{T_{50}})$$

 R_{25} : resistance at absolute temperature T_{25} [K]; T_{25} = 25[°C] + 273.15 = 298.15[K] R_{50} : resistance at absolute temperature T_{50} [K]; T_{50} = 50[°C] + 273.15 = 323.15[K]

Products falling under the subject item No. 2 (41) 3 of Appended Table 1 of the Export Trade Control Order.

Note 2. The symbols represent characteristics of the anti-parallel, source to drain free-wheel diode (FWDi).

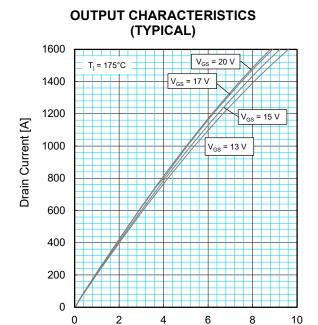
Note 3. Junction temperature (Tj) should not exceed Tjmax rating.

Note 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

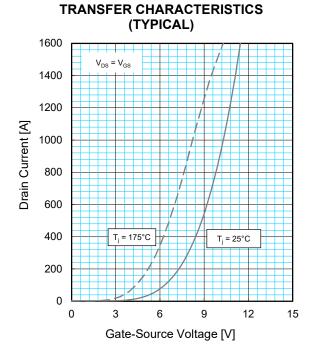
HIGH POWER SWITCHING USE

INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

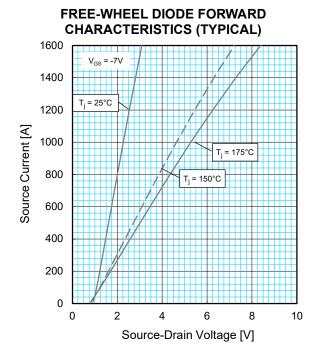
PERFPRMANCE CURVES



Drain-Source Voltage [V]



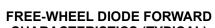
DRAIN-SOURCE ON VOLTAGE CHARACTERISTICS (TYPICAL) 1600 V_{GS} = 17V 1400 $T_i = 25$ °C 1200 Drain Current [A] 1000 T_i = 150°C 800 600 400 200 0 2 6 Drain Source on Voltage [V]

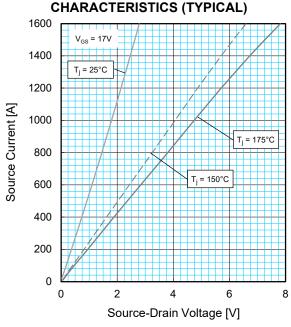


HIGH POWER SWITCHING USE

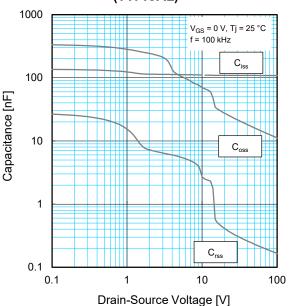
INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

PERFORMANCE CURVES

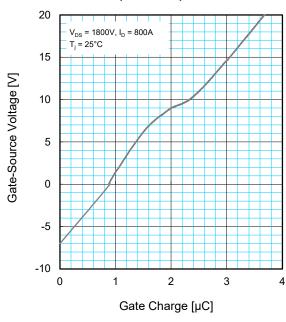




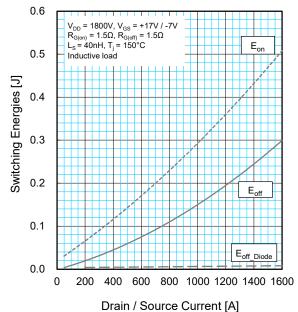
CAPACITANCE CHARACTERISTICS (TYPICAL)



GATE CHARGE CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)

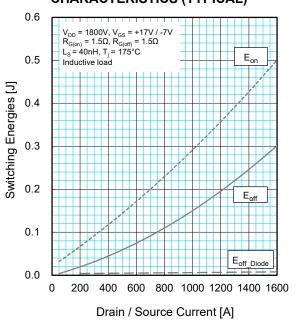


HIGH POWER SWITCHING USE

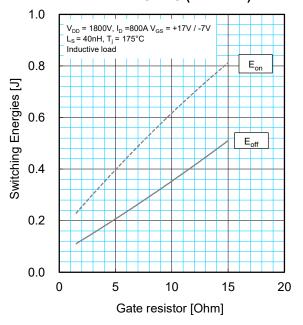
INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

PERFORMANCE CURVES

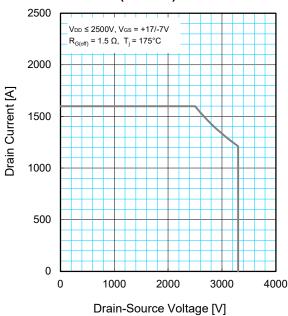
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



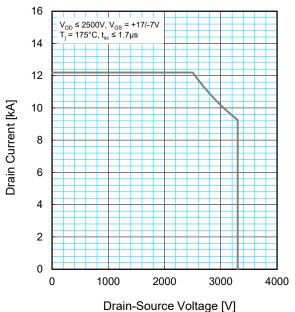
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



REVERSE BIAS SAFE OPERATING AREA (RBSOA)



SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)

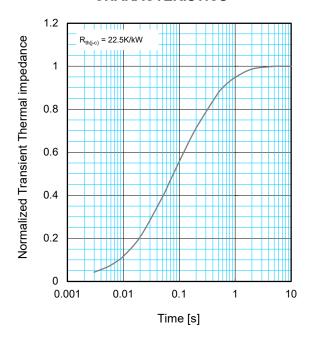


HIGH POWER SWITCHING USE

INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

PERFORMANCE CURVES

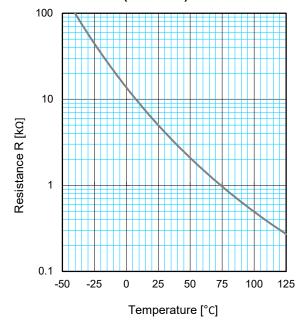
TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - exp^{\left(-\frac{t}{\tau_{i}}\right)} \right\}$$

	1	2	3	4
R _i /R _{th} :	0.0078	0.1975	0.3553	0.4393
τ _i [sec.] :	0.0001	0.7324	0.0381	0.1698

NTC THERMISTOR TEMPERATURE CHARACTERISTICS (TYPICAL)



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HIGH POWER SWITCHING USE

INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

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HIGH POWER SWITCHING USE

INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

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